


<b>Search Notes</b>  	<b>Application/Control No.</b>  10595310	<b>Applicant(s)/Patent Under Reexamination</b>  YAMASHITA ET AL.
	<b>Examiner</b>  SING P CHAN	<b>Art Unit</b>  1791

SEARCHED			
Class	Subclass	Date	Examiner
156	230-235, 246, 247	10/10/08	SPC
428	469, 472	10/10/08	SPC
156	230-235, 246, 247	3/9/09	SPC
428	469, 472	3/9/09	SPC
156	230-235, 246, 247	9/3/09	SPC
428	469, 472	9/3/09	SPC
156	230-235, 246, 247	1/27/10	SPC
428	439, 472	1/27/10	SPC

SEARCH NOTES		
Search Notes	Date	Examiner
Text and image search on EAST	10/10/08	SPC
Inventors search on EAST and PALM akio yamashita, yumiko fukumoto, and yuugo goto	10/10/08	SPC
Text and image search on EAST	3/9/09	SPC
Inventors search on EAST and PALM on akio yamashita, yumiko fukumoto, and yuugo goto	3/9/09	SPC
Text and image search on EAST	9/3/09	SPC
Inventors search on EAST and PALM akio yamashita, yumiko fukumoto, and yuugo goto	9/3/09	SPC
Text and image search on EAST	1/27/10	SPC
Inventors search on EAST and PALM akio yamashita, yumiko fukumoto, and yuugo goto	1/27/10	SPC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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